




SUBSTITUTE FORM PTO-1449A OFFICE OF PATENTS AND APPLICANT'S INFORMATION DISCLOSURE STATEMENT	Atty Docket:	62601_CON1
	Serial No.:	10/716,994
	Applicant:	MEARS ET AL.
	Filing Date:	11/19/03
	Group:	2818

U.S. PATENT DOCUMENTS							
Examiner Initials		Document Number	Date	Name	Class	Sub Class	Filing Date
TTN	AA	4,882,609	11/21/89	Schubert et al.	357	22	
	AB	5,081,513	1/14/92	Jackson et al.	357	23.7	
	AC	5,606,177	2/25/97	Wallace et al.	257	25	
	AD	6,255,150	7/3/01	Wilk et al.	438	191	
TTN	AE	4,908,678	3/13/90	Yamazaki	357	4	
	AF						
	AG						
	AH						
	AI						
	AJ						
	AK						
	AL						
FOREIGN PATENT DOCUMENTS							
		Document Number	Date	Country	Class	Sub Class	Translation
TTN	AM	0 843 361	5/20/98	EP	H01L29	76	
	AN						
	AO						
	AP						
OTHER ART (Including Author, Title, Date, Pertinent Pages, etc.)							
TTN	AQ	Patent Abstracts of Japan, Vol. 012, No. 080 (E-590), 12 March 1988 & JP 62 219665 A (Fujitsu Ltd), 26 September 1987 abstract					
TTN	AR	Patent Abstracts of Japan, Vol. 010, No. 179 (E-414), 24 June 1986 & JP 61 027681 A (Res Dev Corp of Japan), 7 February 1986 abstract					
	AS						

EXAMINER: 	DATE CONSIDERED: 5/16/2005
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\*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

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<b>INFORMATION DISCLOSURE STATEMENT</b>	Atty Docket:	62601_CON1
	Serial No.:	Not Yet Assigned
	Applicant:	MEARS
	Filing Date:	Herewith
	Group:	

## U.S. PATENT DOCUMENTS

Examiner Initials		Document Number	Date	Name	Class	Sub Class	Filing Date
TTN	AA	4,594,603	06/10/86	Holonyak, Jr.	357	16	01/24/85
TTN	AB	4,937,204	08/26/90	Ishibashi et al.	437	110	01/4/89
TTN	AC	4,969,031	11/06/90	Kobayashi et al.	357	63	02/3/83
TTN	AD	5,05,887	10/08/91	Yamazaki	357	4	01/18/90
TTN	AE	5,216,262	06/1/93	Tsu	257	17	03/2/92
	AF	5,357,119	10/18/94	Wang et al.	257	18	02/19/93
	AG	5,684,817	11/04/97	Houdre et al.	372	45	05/1/96
	AH	5,683,934	11/4/03	Candelaria	437	134	05/3/96
	AI	5,994,164	11/30/99	Fonash et al.	438	97	03/18/98
	AJ	6,058,127	05/2/00	Joannopoulos et al.	372	92	12/12/97
	AK	6,274,007	08/14/01	Smimov et al.	204	192	03/14/00
	AL	6,281,518	08/28/01	Sato	257	13	12/3/98
	AM	6,281,532	08/28/01	Doyle et al.	257	288	06/28/99
	AN	6,344,271	02/05/02	Yadav et al.	428	402	03/23/99
	AO	6,472,685	10/29/02	Takagi	257	77	12/2/98
	AP	6,498,359	12/24/02	Schmidt et al.	257	190	05/18/01
	AQ	2003/ 0034529	02/20/03	Fitzgerald et al.	257	369	10/8/02
TTN	AR	2003/ 0057416	03/27/03	Currie et al.	257	19	09/20/02

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		Document Number	Date	Country	Class	Sub Class	Translation
TTN	AS	02/103767	12/27/02	WO	H01L	21/20	—
TTN	AT	2,347,520	09/06/00	GB	G02B	5/18	—
	AU						

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